

10/035186



10/035186

U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM 10035186	FILING DATE 01/04/2002	CLASS 334 438	SUBCLASS -	GAU 2812	EXAMINER KARLSEN
**APPLICANTS: Das Gobinda: Motika Franco: <i>SBG</i> <i>2129</i>					
**CONTINUING DATA VERIFIED: THIS APPLICATION IS A DIV OF 09/615,198 07/13/2000 <i>ABN</i> <i>SBG</i>					
** FOREIGN APPLICATIONS VERIFIED: <i>NONE SBG</i>					
PG-PUB DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed 35 USC 110 conditions met Verified and Acknowledged Examiners's initials		<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <i>SBG</i>		ATTORNEY DOCKET NO BUR9-1999-0278-US1	
TITLE : TF: probe I/O wrap test method					

U.S. DEPT. OF COMM. / PAT. & TM. PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
ISSUE FEE		Assistant Examiner	
Amount Due	Date Paid	Primary Examiner	
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE	
		Application Examiner	
WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.			

FILED WITH:

☐ DISK (CRF)

☐ CD-ROM

(Attached in pocket on right inside flap)